## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,356	TAKASE ET AL.
Examiner	Art Unit

1791

EDMUND H. LEE

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
264/272.1	5,272.17,275	7/10/2009	EHL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
(INCLUDING SEARCH	DATE	EXMR		
UPDATED	7/10/2009	EHL		